

Applic	ation/Con	trol	No.

10/830,214 Examiner

Joannie A. García

Applicant(s)/Patent under Reexamination

OH ET AL. Art Unit

2823

ISSUE CLASSIFICATION												
ORIGINAL		CROSS REFERENCE(S)										
CLASS SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)										
438 396	438	240 253 785 957										
INTERNATIONAL CLASSIFICATION												
H 1 0 L 21/8242												
Joannie Adelle Garcia 0 (Assistant Examiner) (Da		Total Claims Allowed: 15 George Fourson										
) I NOTALLA (j.egal Instruments Examiner)	711405 (Date)	Primary Examiner 4 (3/65 Print Claim(s) Print Fig. (Primary Examiner) (Date) 1 1i										

☐ Claims renumbered in the same order as presented by applicant										☐ CPA ☐ T.D.				☐.R.1.47					
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5	6			36]		66]		96			126			156			186
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11	12]		42]		72			102			132			162			192
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